



Welcome to E-XFL.COM

What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

Details

Product Status	Active
Core Processor	PIC
Core Size	8-Bit
Speed	20MHz
Connectivity	-
Peripherals	POR, WDT
Number of I/O	20
Program Memory Size	768B (512 x 12)
Program Memory Type	OTP
EEPROM Size	-
RAM Size	24 x 8
Voltage - Supply (Vcc/Vdd)	4.5V ~ 5.5V
Data Converters	-
Oscillator Type	External
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	28-SOIC (0.295", 7.50mm Width)
Supplier Device Package	28-SOIC
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/pic16c55-hsi-so

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Pin Diagrams



Device Differences

Device	Voltage Range	Oscillator Selection (Program)	Oscillator	Process Technology (Microns)	ROM Equivalent	MCLR Filter
PIC16C54	2.5-6.25	Factory	See Note 1	1.2	PIC16CR54A	No
PIC16C54A	2.0-6.25	User	See Note 1	0.9	—	No
PIC16C54C	2.5-5.5	User	See Note 1	0.7	PIC16CR54C	Yes
PIC16C55	2.5-6.25	Factory	See Note 1	1.7	_	No
PIC16C55A	2.5-5.5	User	See Note 1	0.7	—	Yes
PIC16C56	2.5-6.25	Factory	See Note 1	1.7	—	No
PIC16C56A	2.5-5.5	User	See Note 1	0.7	PIC16CR56A	Yes
PIC16C57	2.5-6.25	Factory	See Note 1	1.2	—	No
PIC16C57C	2.5-5.5	User	See Note 1	0.7	PIC16CR57C	Yes
PIC16C58B	2.5-5.5	User	See Note 1	0.7	PIC16CR58B	Yes
PIC16CR54A	2.5-6.25	Factory	See Note 1	1.2	N/A	Yes
PIC16CR54C	2.5-5.5	Factory	See Note 1	0.7	N/A	Yes
PIC16CR56A	2.5-5.5	Factory	See Note 1	0.7	N/A	Yes
PIC16CR57C	2.5-5.5	Factory	See Note 1	0.7	N/A	Yes
PIC16CR58B	2.5-5.5	Factory	See Note 1	0.7	N/A	Yes

Note 1: If you change from this device to another device, please verify oscillator characteristics in your application.

Note: The table shown above shows the generic names of the PIC16C5X devices. For device varieties, please refer to Section 2.0.

Table of Contents

4.0		-
1.0	General Description	5
2.0	PIC16C5X Device Varieties	7
3.0	Architectural Overview	9
4.0	Oscillator Configurations	. 15
5.0	Reset	. 19
6.0	Memory Organization	. 25
7.0	I/O Ports	. 35
8.0	Timer0 Module and TMR0 Register	. 37
9.0	Special Features of the CPU	. 43
10.0	Instruction Set Summary	. 49
11.0	Development Support	. 61
12.0	Electrical Characteristics - PIC16C54/55/56/57	. 67
13.0	Electrical Characteristics - PIC16CR54A	. 79
14.0	Device Characterization - PIC16C54/55/56/57/CR54A	. 91
15.0	Electrical Characteristics - PIC16C54A	103
16.0	Device Characterization - PIC16C54A	117
17.0	Electrical Characteristics - PIC16C54C/CR54C/C55A/C56A/CR56A/C57C/CR57C/C58B/CR58B	131
18.0	Device Characterization - PIC16C54C/CR54C/C55A/C56A/CR56A/CR56A/CR57C/CR57C/C58B/CR58B	145
19.0	Electrical Characteristics - PIC16C54C/C55A/C56A/C57C/C58B 40MHz	155
20.0	Device Characterization - PIC16C54C/C55A/C56A/C57C/C58B 40MHz	165
21.0	Packaging Information	171
Appe	ndix A: Compatibility	182
On-L	ne Support	187
Read	er Response	188
Produ	uct Identification System	189

TO OUR VALUED CUSTOMERS

It is our intention to provide our valued customers with the best documentation possible to ensure successful use of your Microchip products. To this end, we will continue to improve our publications to better suit your needs. Our publications will be refined and enhanced as new volumes and updates are introduced.

If you have any questions or comments regarding this publication, please contact the Marketing Communications Department via E-mail at **docerrors@mail.microchip.com** or fax the **Reader Response Form** in the back of this data sheet to (480) 792-4150. We welcome your feedback.

Most Current Data Sheet

To obtain the most up-to-date version of this data sheet, please register at our Worldwide Web site at:

http://www.microchip.com

You can determine the version of a data sheet by examining its literature number found on the bottom outside corner of any page. The last character of the literature number is the version number, (e.g., DS30000A is version A of document DS30000).

Errata

An errata sheet, describing minor operational differences from the data sheet and recommended workarounds, may exist for current devices. As device/documentation issues become known to us, we will publish an errata sheet. The errata will specify the revision of silicon and revision of document to which it applies.

To determine if an errata sheet exists for a particular device, please check with one of the following:

- Microchip's Worldwide Web site; http://www.microchip.com
- Your local Microchip sales office (see last page)
- The Microchip Corporate Literature Center; U.S. FAX: (480) 792-7277

When contacting a sales office or the literature center, please specify which device, revision of silicon and data sheet (include literature number) you are using.

Customer Notification System

Register on our web site at www.microchip.com/cn to receive the most current information on all of our products.

4.3 External Crystal Oscillator Circuit

Either a prepackaged oscillator or a simple oscillator circuit with TTL gates can be used as an external crystal oscillator circuit. Prepackaged oscillators provide a wide operating range and better stability. A welldesigned crystal oscillator will provide good performance with TTL gates. Two types of crystal oscillator circuits can be used: one with parallel resonance, or one with series resonance.

Figure 4-3 shows an implementation example of a parallel resonant oscillator circuit. The circuit is designed to use the fundamental frequency of the crystal. The 74AS04 inverter performs the 180-degree phase shift that a parallel oscillator requires. The 4.7 k Ω resistor provides the negative feedback for stability. The 10 k Ω potentiometers bias the 74AS04 in the linear region. This circuit could be used for external oscillator designs.

FIGURE 4-3: EXAMPLE OF EXTERNAL PARALLEL RESONANT CRYSTAL OSCILLATOR CIRCUIT (USING XT, HS OR LP OSCILLATOR MODE)



Figure 4-4 shows a series resonant oscillator circuit. This circuit is also designed to use the fundamental frequency of the crystal. The inverter performs a 180-degree phase shift in a series resonant oscillator circuit. The 330 k Ω resistors provide the negative feedback to bias the inverters in their linear region.



6.5.1 PAGING CONSIDERATIONS – PIC16C56/CR56, PIC16C57/CR57 AND PIC16C58/CR58

If the Program Counter is pointing to the last address of a selected memory page, when it increments it will cause the program to continue in the next higher page. However, the page preselect bits in the STATUS Register will not be updated. Therefore, the next GOTO, CALL or modify PCL instruction will send the program to the page specified by the page preselect bits (PA0 or PA<1:0>).

For example, a NOP at location 1FFh (page 0) increments the PC to 200h (page 1). A GOTO xxx at 200h will return the program to address xxh on page 0 (assuming that PA<1:0> are clear).

To prevent this, the page preselect bits must be updated under program control.

6.5.2 EFFECTS OF RESET

The Program Counter is set upon a RESET, which means that the PC addresses the last location in the last page (i.e., the RESET vector).

The STATUS Register page preselect bits are cleared upon a RESET, which means that page 0 is pre-selected.

Therefore, upon a RESET, a GOTO instruction at the RESET vector location will automatically cause the program to jump to page 0.

6.6 Stack

PIC16C5X devices have a 10-bit or 11-bit wide, two-level hardware push/pop stack.

A CALL instruction will push the current value of stack 1 into stack 2 and then push the current program counter value, incremented by one, into stack level 1. If more than two sequential CALL's are executed, only the most recent two return addresses are stored.

A RETLW instruction will pop the contents of stack level 1 into the program counter and then copy stack level 2 contents into level 1. If more than two sequential RETLW's are executed, the stack will be filled with the address previously stored in level 2. Note that the W Register will be loaded with the literal value specified in the instruction. This is particularly useful for the implementation of data look-up tables within the program memory.

For the RETLW instruction, the PC is loaded with the Top of Stack (TOS) contents. All of the devices covered in this data sheet have a two-level stack. The stack has the same bit width as the device PC, therefore, paging is not an issue when returning from a subroutine.

7.6 I/O Programming Considerations

7.6.1 BI-DIRECTIONAL I/O PORTS

Some instructions operate internally as read followed by write operations. The BCF and BSF instructions, for example, read the entire port into the CPU, execute the bit operation and re-write the result. Caution must be used when these instructions are applied to a port where one or more pins are used as input/outputs. For example, a BSF operation on bit5 of PORTB will cause all eight bits of PORTB to be read into the CPU, bit5 to be set and the PORTB value to be written to the output latches. If another bit of PORTB is used as a bi-directional I/O pin (say bit0) and it is defined as an input at this time, the input signal present on the pin itself would be read into the CPU and rewritten to the data latch of this particular pin, overwriting the previous content. As long as the pin stays in the Input mode, no problem occurs. However, if bit0 is switched into Output mode later on, the content of the data latch may now be unknown.

Example 7-1 shows the effect of two sequential read-modify-write instructions (e.g., BCF, BSF, etc.) on an I/O port.

A pin actively outputting a high or a low should not be driven from external devices at the same time in order to change the level on this pin ("wired-or", "wired-and"). The resulting high output currents may damage the chip.

EXAMPLE 7-1: READ-MODIFY-WRITE INSTRUCTIONS ON AN I/O PORT

;Initial PORT Settings
; PORTB<7:4> Inputs
; PORTB<3:0> Outputs
;PORTB<7:6> have external pull-ups and are
;not connected to other circuitry
;

;				PORT	latch	PORT	pins
;							
	BCF	PORTB,	7	;01pp	pppp	11pp	pppp
	BCF	PORTB,	6	;10pp	pppp	11pp	pppp
	MOVLW	H'3F'		;			
	TRIS	PORTB		;10pp	pppp	10pp	pppp
;							

;Note that the user may have expected the pin ;values to be 00pp pppp. The 2nd BCF caused ;RB7 to be latched as the pin value (High).

7.6.2 SUCCESSIVE OPERATIONS ON I/O PORTS

The actual write to an I/O port happens at the end of an instruction cycle, whereas for reading, the data must be valid at the beginning of the instruction cycle (Figure 7-2). Therefore, care must be exercised if a write followed by a read operation is carried out on the same I/O port. The sequence of instructions should allow the pin voltage to stabilize (load dependent) before the next instruction, which causes that file to be read into the CPU, is executed. Otherwise, the previous state of that pin may be read into the CPU rather than the new state. When in doubt, it is better to separate these instructions with a NOP or another instruction not accessing this I/O port.



FIGURE 7-2: SUCCESSIVE I/O OPERATION

PIC16C5X

COMF Complement f								
Syntax:	[<i>label</i>] COMF f,d							
Operands:	$\begin{array}{l} 0\leq f\leq 31\\ d\in [0,1] \end{array}$							
Operation:	$(\overline{f}) \rightarrow (dest)$							
Status Affected:	Z							
Encoding:	0010 01df ffff							
Description:	The contents of register 'f' are complemented. If 'd' is 0 the result is stored in the W register. If 'd' is 1 the result is stored back in register 'f'.							
Words:	1							
Cycles:	1							
Example:	COMF REG1,0							
Before Instru	ction							
REG1	= 0x13							
After Instruct	ion							
REG1	= 0x13							
W	= 0xEC							

DECF	Decrement f								
Syntax:	[label] DECF f,d								
Operands:	$\begin{array}{l} 0 \leq f \leq 31 \\ d \in [0,1] \end{array}$								
Operation:	(f) – 1	\rightarrow (dest)							
Status Affected:	Z								
Encoding:	0000	11df	ffff						
Description:	Decrement register 'f'. If 'd' is 0 the result is stored in the W register. If 'd' is 1 the result is stored back in register 'f'.								
Words:	1								
Cycles:	1								
Example:	DECF	CNT,	1						
Before Instruc CNT Z After Instructi CNT Z	ction = = on = =	0x01 0 0x00 1							

DECFSZ	Decrement f, Skip if 0							
Syntax:	[label] DECFSZ f,d							
Operands:	$\begin{array}{l} 0 \leq f \leq 31 \\ d \in [0,1] \end{array}$							
Operation:	$(f) - 1 \rightarrow d;$ skip if result = 0							
Status Affected:	None							
Encoding:	0010 11df ffff							
Description:	The contents of register 'f' are dec- remented. If 'd' is 0 the result is placed in the W register. If 'd' is 1 the result is placed back in register 'f'. If the result is 0, the next instruc- tion, which is already fetched, is discarded and a NOP is executed instead making it a two-cycle							
Words:	1							
Cycles:	1(2)							
Example:	HERE DECFSZ CNT, 1 GOTO LOOP							
	CONTINUE • • •							
Before Instru	uction							
PC	= address (HERE)							
After Instruc	tion							
CNT	= CNT - 1;							
IT CN I	= 0,							
	= address (CONTINUE);							
	\neq U, - address (UFDF, 1)							
FU	= addless (HERE+1)							

12.5 DC Characteristics: PIC16C54/55/56/57-RCE, XTE, 10E, HSE, LPE (Extended)

DC CH	ARACTE	RISTICS	Standard Operating Conditions (unless otherwise specified)Operating Temperature $-40^{\circ}C \le TA \le +125^{\circ}C$ for extended					
Param No.	Symbol	Characteristic	Min	Тур†	Мах	Units	Conditions	
D030	Vil	Input Low Voltage I/O ports MCLR (Schmitt Trigger) T0CKI (Schmitt Trigger) OSC1 (Schmitt Trigger) OSC1 (Schmitt Trigger)	Vss Vss Vss Vss Vss Vss		0.15 VDD 0.15 VDD 0.15 VDD 0.15 VDD 0.15 VDD 0.3 VDD	V V V V	Pin at hi-impedance PIC16C5X-RC only ⁽³⁾ PIC16C5X-XT, 10, HS, LP	
D040	Vih	Input High Voltage I/O ports I/O ports I/O ports MCLR (Schmitt Trigger) T0CKI (Schmitt Trigger) OSC1 (Schmitt Trigger) OSC1 (Schmitt Trigger)	0.45 VDD 2.0 0.36 VDD 0.85 VDD 0.85 VDD 0.85 VDD 0.7 VDD		VDD VDD VDD VDD VDD VDD VDD VDD	V V V V V V V	For all $V_{DD}^{(4)}$ 4.0V < $V_{DD} \le 5.5V^{(4)}$ $V_{DD} > 5.5 V$ PIC16C5X-RC only ⁽³⁾ PIC16C5X-XT, 10, HS, LP	
D050	VHYS	Hysteresis of Schmitt Trigger inputs	0.15 Vdd*	—	—	V		
D060	Ιι∟	Input Leakage Current ^(1,2) I/O ports MCLR MCLR T0CKI OSC1	-1 -5 - -3 -3	0.5 — 0.5 0.5 0.5	+1 +5 +3 +3	μΑ μΑ μΑ μΑ μΑ	$\label{eq:statestar} \begin{array}{l} \mbox{For Vdd} \leq \mbox{5.5 V:} \\ \mbox{Vss} \leq \mbox{VplN} \leq \mbox{Vdd}, \\ \mbox{pin at hi-impedance} \\ \mbox{VplN} = \mbox{Vss} + \mbox{0.25V} \\ \mbox{VplN} = \mbox{Vdd} \\ \mbox{VplN} = \mbox{Vdd} \\ \mbox{Vss} \leq \mbox{VplN} \leq \mbox{Vdd} \\ \mbox{Vss} \leq \mbox{VplN} \leq \mbox{Vdd} \\ \mbox{Vss} \leq \mbox{VplN} \leq \mbox{Vdd} \\ \mbox{PlC16C5X-XT, 10, HS, LP} \end{array}$	
D080	Vol	Output Low Voltage I/O ports OSC2/CLKOUT	—	_	0.6 0.6	V V	IOL = 8.7 mA, VDD = 4.5V IOL = 1.6 mA, VDD = 4.5V, PIC16C5X-RC	
D090	Voн	Output High Voltage ⁽²⁾ I/O ports OSC2/CLKOUT	VDD - 0.7 VDD - 0.7			V V	IOH = -5.4 mA, VDD = 4.5V IOH = -1.0 mA, VDD = 4.5V, PIC16C5X-RC	

These parameters are characterized but not tested.

† Data in the Typical ("Typ") column is based on characterization results at 25°C. This data is for design guidance only and is not tested.

Note 1: The leakage current on the MCLR/VPP pin is strongly dependent on the applied voltage level. The specified levels represent normal operating conditions. Higher leakage current may be measured at different input voltage.

2: Negative current is defined as coming out of the pin.

3: For PIC16C5X-RC devices, the OSC1/CLKIN pin is a Schmitt Trigger input. It is not recommended that the PIC16C5X be driven with external clock in RC mode.

4: The user may use the better of the two specifications.

13.0 ELECTRICAL CHARACTERISTICS - PIC16CR54A

Absolute Maximum Ratings(†)

Ambient Temperature under bias	55°C to +125°C
Storage Temperature	65°C to +150°C
Voltage on VDD with respect to Vss	0 to +7.5V
Voltage on MCLR with respect to Vss ⁽¹⁾	0 to +14V
Voltage on all other pins with respect to Vss	0.6V to (VDD + 0.6V)
Total power dissipation ⁽²⁾	
Max. current out of Vss pin	150 mA
Max. current into Vod pin	50 mA
Max. current into an input pin (T0CKI only)	±500 μA
Input clamp current, Iık (VI < 0 or VI > VDD)	±20 mA
Output clamp current, IOK (V0 < 0 or V0 > VDD)	±20 mA
Max. output current sunk by any I/O pin	25 mA
Max. output current sourced by any I/O pin	20 mA
Max. output current sourced by a single I/O port (PORTA or B)	40 mA
Max. output current sunk by a single I/O port (PORTA or B)	50 mA

- **Note 1:** Voltage spikes below Vss at the $\overline{\text{MCLR}}$ pin, inducing currents greater than 80 mA may cause latch-up. Thus, a series resistor of 50 to 100 Ω should be used when applying a low level to the $\overline{\text{MCLR}}$ pin rather than pulling this pin directly to Vss.
 - **2:** Power Dissipation is calculated as follows: PDIS = VDD x {IDD \sum IOH} + \sum {(VDD-VOH) x IOH} + \sum (VOL x IOL)

† NOTICE: Stresses above those listed under "Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operation listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

13.4 DC Characteristics: PIC16CR54A-04E, 10E, 20E (Extended)

DC CH	ARACTE	RISTICS	Standard Operating Conditions (unless otherwise specified)Operating Temperature $-40^{\circ}C \le TA \le +125^{\circ}C$ for extended					
Param No.	Symbol	Characteristic	Min	Тур†	Мах	Units	Conditions	
D030	VIL	Input Low Voltage I/O ports MCLR (Schmitt Trigger) T0CKI (Schmitt Trigger) OSC1 (Schmitt Trigger) OSC1	Vss Vss Vss Vss Vss		0.15 VDD 0.15 VDD 0.15 VDD 0.15 VDD 0.15 VDD 0.3 VDD	V V V V	Pin at hi-impedance RC mode only ⁽³⁾ XT, HS and LP modes	
D040	Vih	Input High Voltage I/O ports I/O ports I/O ports MCLR (Schmitt Trigger) T0CKI (Schmitt Trigger) OSC1 (Schmitt Trigger) OSC1	0.45 VDD 2.0 0.36 VDD 0.85 VDD 0.85 VDD 0.85 VDD 0.85 VDD 0.7 VDD		VDD VDD VDD VDD VDD VDD VDD VDD	V V V V V V V	For all VDD ⁽⁴⁾ 4.0V < VDD ≤ 5.5V ⁽⁴⁾ VDD > 5.5V RC mode only ⁽³⁾ XT, HS and LP modes	
D050	VHYS	Hysteresis of Schmitt Trigger inputs	0.15 Vdd*	—	—	V		
D060	lı∟	Input Leakage Current ^(1,2) I/O ports MCLR MCLR T0CKI OSC1	-1.0 -5.0 -3.0 -3.0	0.5 — 0.5 0.5 0.5	+1.0 	μΑ μΑ μΑ μΑ	$\label{eq:For VDD} \begin{split} & \leq \textbf{5.5V:} \\ & \forall SS \leq \forall PIN \leq \forall DD, \\ & pin \text{ at hi-impedance} \\ & \forall PIN = \forall SS + 0.25 \forall \\ & \forall PIN = \forall DD \\ & \forall SS \leq \forall \forall PIN \leq \forall DD \\ & \forall SS \leq \forall \forall PIN \leq \forall DD, \\ & \forall XT, \ HS \text{ and } \ LP \ modes \end{split}$	
D080	Vol	Output Low Voltage I/O ports OSC2/CLKOUT		_	0.6 0.6	V V	IOL = 8.7 mA, VDD = 4.5V IOL = 1.6 mA, VDD = 4.5V, RC mode only	
D090	Vон	Output High Voltage ⁽²⁾ I/O ports OSC2/CLKOUT	VDD - 0.7 VDD - 0.7			V V	IOH = -5.4 mA, VDD = 4.5 V IOH = -1.0 mA, VDD = 4.5 V, RC mode only	

These parameters are characterized but not tested.

† Data in the Typical ("Typ") column is based on characterization results at 25°C. This data is for design guidance only and is not tested.

Note 1: The leakage current on the MCLR/VPP pin is strongly dependent on the applied voltage level. The specified levels represent normal operating conditions. Higher leakage current may be measured at different input voltage.

2: Negative current is defined as coming out of the pin.

3: For the RC mode, the OSC1/CLKIN pin is a Schmitt Trigger input. It is not recommended that the PIC16C5X be driven with external clock in RC mode.

4: The user may use the better of the two specifications.

FIGURE 14-6: MAXIMUM IPD vs. VDD, WATCHDOG DISABLED



FIGURE 14-7: TYPICA

TYPICAL IPD vs. VDD, WATCHDOG ENABLED



FIGURE 14-8: MAXIMUM IPD vs. VDD, WATCHDOG ENABLED



IPD, with WDT enabled, has two components: The leakage current, which increases with higher temperature, and the operating current of the WDT logic, which increases with lower temperature. At -40° C, the latter dominates explaining the apparently anomalous behavior.

15.2 DC Characteristics: PIC16

PIC16C54A-04E, 10E, 20E (Extended) PIC16LC54A-04E (Extended)

PIC16LC54A-04E (Extended)				ard Ope ting Terr	rating	j Condi ure	tions (unless otherwise specified) $-40^{\circ}C \le TA \le +125^{\circ}C$ for extended
PIC16C54A-04E, 10E, 20E (Extended)			$\begin{array}{llllllllllllllllllllllllllllllllllll$				
Param No.	Symbol	Characteristic	Min	Тур†	Max	Units	Conditions
	IPD	Power-down Current ⁽²⁾					
D020		PIC16LC54A	—	2.5	15	μΑ	VDD = 2.5V, WDT enabled,
			_	0.25	7.0	μA	Extended VDD = 2.5V, WDT disabled, Extended
D020A		PIC16C54A	—	5.0	22	μA	VDD = 3.5V, WDT enabled
				0.8	18^	μΑ	VDD = $3.5V$, VVD I disabled

Legend: Rows with standard voltage device data only are shaded for improved readability.

* These parameters are characterized but not tested.

- † Data in the Typical ("Typ") column is based on characterization results at 25°C. This data is for design guidance only and is not tested.
- **Note 1:** This is the limit to which VDD can be lowered in SLEEP mode without losing RAM data.
 - 2: The supply current is mainly a function of the operating voltage and frequency. Other factors such as bus loading, oscillator type, bus rate, internal code execution pattern and temperature also have an impact on the current consumption.
 - a) The test conditions for all IDD measurements in active Operation mode are: OSC1 = external square wave, from rail-to-rail; all I/O pins tristated, pulled to Vss, T0CKI = VDD, MCLR = VDD; WDT enabled/ disabled as specified.
 - b) For standby current measurements, the conditions are the same, except that the device is in SLEEP mode. The power-down current in SLEEP mode does not depend on the oscillator type.
 - **3:** Does not include current through REXT. The current through the resistor can be estimated by the formula: IR = VDD/2REXT (mA) with REXT in k Ω .

© 1997-2013 Microchip Technology Inc.

Typical: statistical mean @ 25°C. Maximum: mean - 3 s (-40°C to 125°C) Minimum: mean

FIGURE 16-14: TYPICAL IDD vs. FREQUENCY (WDT DISABLED, RC MODE @ 300 PF, 25°C)

FIGURE 16-15: MAXIMUM IDD vs. FREQUENCY (WDT DISABLED, RC MODE @ 300 PF, -40°C to +85°C)





FIGURE 16-21: PORTA, B AND C IOH vs. VOH, VDD = 5V



TABLE 17-1: EXTERNAL CLOCK TIMING REQUIREMENTS - PIC16C5X, PIC16CR5X

AC Chara	cteristics	$ \begin{array}{ll} \mbox{Standard Operating Conditions (unless otherwise specified)} \\ \mbox{Operating Temperature} & 0^{\circ}C \leq TA \leq +70^{\circ}C \mbox{ for commercial} \\ -40^{\circ}C \leq TA \leq +85^{\circ}C \mbox{ for industrial} \\ -40^{\circ}C \leq TA \leq +125^{\circ}C \mbox{ for extended} \\ \end{array} $					
Param No. Symbol		Characteristic	Min	Тур†	Мах	Units	Conditions
2	Тсу	Instruction Cycle Time ⁽²⁾	—	4/Fosc			
3	TosL, TosH	Clock in (OSC1) Low or High	50*		_	ns	XT oscillator
		Time	20*	—	_	ns	HS oscillator
			2.0*	—	_	μS	LP oscillator
4	TosR, TosF	Clock in (OSC1) Rise or Fall	-		25*	ns	XT oscillator
		Time	—	—	25*	ns	HS oscillator
			—	—	50*	ns	LP oscillator

- * These parameters are characterized but not tested.
- † Data in the Typical ("Typ") column is at 5V, 25°C unless otherwise stated. These parameters are for design guidance only and are not tested.
- **Note 1:** All specified values are based on characterization data for that particular oscillator type under standard operating conditions with the device executing code. Exceeding these specified limits may result in an unstable oscillator operation and/or higher than expected current consumption.

When an external clock input is used, the "max" cycle time limit is "DC" (no clock) for all devices.

2: Instruction cycle period (TCY) equals four times the input oscillator time base period.



FIGURE 17-8: RESET, WATCHDOG TIMER, AND DEVICE RESET TIMER TIMING - PIC16C5X, PIC16CR5X

TABLE 17-3: RESET, WATCHDOG TIMER, AND DEVICE RESET TIMER - PIC16C5X, PIC16CR5X

AC Characteristics		$\begin{array}{ll} \mbox{Standard Operating Conditions (unless otherwise specified)} \\ \mbox{Operating Temperature} & 0^{\circ}C \leq TA \leq +70^{\circ}C \mbox{ for commercial} \\ -40^{\circ}C \leq TA \leq +85^{\circ}C \mbox{ for industrial} \\ -40^{\circ}C \leq TA \leq +125^{\circ}C \mbox{ for extended} \end{array}$						
Param No.	Symbol	Characteristic	Min	Тур†	Max	Units	Conditions	
30	TmcL	MCLR Pulse Width (low)	1000*		—	ns	VDD = 5.0V	
31	Twdt	Watchdog Timer Time-out Period (No Prescaler)	9.0*	18*	30*	ms	VDD = 5.0V (Comm)	
32	Tdrt	Device Reset Timer Period	9.0*	18*	30*	ms	VDD = 5.0V (Comm)	
34	Tioz	I/O Hi-impedance from MCLR Low	100*	300*	1000*	ns		

* These parameters are characterized but not tested.

† Data in the Typical ("Typ") column is at 5V, 25°C unless otherwise stated. These parameters are for design guidance only and are not tested.

© 1997-2013 Microchip Technology Inc.

FIGURE 17-9: TIMER0 CLOCK TIMINGS - PIC16C5X, PIC16CR5X



TABLE 17-4: TIMER0 CLOCK REQUIREMENTS - PIC16C5X, PIC16CR5X

AC CharacteristicsStandard Operating Conditions (unless otherwise specified) Operating Temperature $0^{\circ}C \le TA \le +70^{\circ}C$ for commercial $-40^{\circ}C \le TA \le +85^{\circ}C$ for industrial $-40^{\circ}C \le TA \le +125^{\circ}C$ for extended					nercial rial nded	
Symbol	Characteristic	Min	Тур†	Max	Units	Conditions
Tt0H	T0CKI High Pulse Width - No Prescaler	0.5 Tcy + 20*		_	ns	
	- With Prescaler	10*	—	—	ns	
TtOL	T0CKI Low Pulse Width - No Prescaler	0.5 Tcy + 20*	_	_	ns	
	- With Prescaler	10*	—	_	ns	
Tt0P	T0CKI Period	20 or <u>Tcy + 40</u> * N		—	ns	Whichever is greater. N = Prescale Value (1, 2, 4,, 256)
	Symbol Tt0H Tt0L Tt0P	Symbol Characteristic Tt0H T0CKI High Pulse Width - No Prescaler - With Prescaler Tt0L T0CKI Low Pulse Width - No Prescaler - With Prescaler Tt0P T0CKI Period	SymbolCharacteristicMinTt0HT0CKI High Pulse Width - No Prescaler - With Prescaler $0.5 \text{ Tcy} + 20^*$ Tt0LT0CKI Low Pulse Width - No Prescaler - With Prescaler $0.5 \text{ Tcy} + 20^*$ Tt0LT0CKI Low Pulse Width - No Prescaler - With Prescaler $0.5 \text{ Tcy} + 20^*$ Tt0PT0CKI Period $0.5 \text{ Tcy} + 40^*$ Tt0PT0CKI Period $20 \text{ or } \frac{\text{Tcy} + 40^*}{\text{N}}$	SymbolCharacteristics $-40^{\circ}C \le TA \le +8$ $-40^{\circ}C \le TA \le +1$ SymbolCharacteristicMinTyptTt0HT0CKI High Pulse Width $- No Prescaler$ $0.5 TcY + 20^{*}$ $-$ $-$ Tt0LT0CKI Low Pulse Width $- No Prescaler$ $0.5 TcY + 20^{*}$ $-$ Tt0LT0CKI Low Pulse Width $- No Prescaler$ $0.5 TcY + 20^{*}$ $-$ Tt0PT0CKI Period $0.5 TcY + 20^{*}$ $-$ Tt0PT0CKI Period $20 \text{ or } TcY + 40^{*}$ $-$	-40°C \leq TA \leq +85°C fc -40°C \leq TA \leq +125°C fSymbolCharacteristicMinTyp†MaxTt0HT0CKI High Pulse Width - No Prescaler0.5 Tcy + 20*With Prescaler10*Tt0LT0CKI Low Pulse Width - No Prescaler0.5 Tcy + 20*Tt0LT0CKI Low Pulse Width - No Prescaler0.5 Tcy + 20*Tt0PT0CKI Period20 or Tcy + 40*Tt0PT0CKI Period20 or Tcy + 40*NN	$-40^{\circ}C \le TA \le +85^{\circ}C$ for indust $-40^{\circ}C \le TA \le +125^{\circ}C$ for exterSymbolCharacteristicMinTyp†MaxUnitsTt0HTOCKI High Pulse Width - No Prescaler - With Prescaler $0.5 TCY + 20^{*}$ nsTt0LTOCKI Low Pulse Width - No Prescaler - With Prescaler $0.5 TCY + 20^{*}$ nsTt0LTOCKI Low Pulse Width - No Prescaler - With Prescaler $0.5 TCY + 20^{*}$ nsTt0PTOCKI Period $20 \text{ or } TCY + 40^{*}$ nsTt0PTOCKI Period $20 \text{ or } TCY + 40^{*}$ ns

These parameters are characterized but not tested.

† Data in the Typical ("Typ") column is at 5V, 25°C unless otherwise stated. These parameters are for design guidance only and are not tested.

PIC16C5X

FIGURE 18-10: VTH (INPUT THRESHOLD TRIP POINT VOLTAGE) OF OSC1 INPUT (IN XT, HS AND LP MODES) vs. VDD









	ALVAUT AND VA THING BEALIDENENTA DIA AASY (A
IABLE 19-2:	CLKOUT AND I/O TIMING REQUIREMENTS - PIC16C5X-40

AC Characteristics		Standard Operating Conditions (unless otherwise specified)Operating Temperature $0^{\circ}C \le TA \le +70^{\circ}C$ for commercial						
Param No.	Symbol	Characteristic	Min	Тур†	Max	Units		
10	TosH2ckL	OSC1↑ to CLKOUT↓ ^(1,2)		15	30**	ns		
11	TosH2ckH	OSC1↑ to CLKOUT↑ ^(1,2)	—	15	30**	ns		
12	TckR	CLKOUT rise time ^(1,2)	—	5.0	15**	ns		
13	TckF	CLKOUT fall time ^(1,2)	—	5.0	15**	ns		
14	TckL2ioV	CLKOUT↓ to Port out valid ^(1,2)	—		40**	ns		
15	TioV2ckH	Port in valid before CLKOUT ^(1,2)	0.25 TCY+30*	—	—	ns		
16	TckH2iol	Port in hold after CLKOUT ^(1,2)	0*	—	—	ns		
17	TosH2ioV	OSC1 [↑] (Q1 cycle) to Port out valid ⁽²⁾	—	—	100	ns		
18	TosH2iol	OSC1↑ (Q2 cycle) to Port input invalid (I/O in hold time)	TBD	—	—	ns		
19	TioV2osH	Port input valid to OSC1↑ (I/O in setup time)	TBD	—	—	ns		
20	TioR	Port output rise time ⁽²⁾	—	10	25**	ns		
21	TioF	Port output fall time ⁽²⁾		10	25**	ns		

* These parameters are characterized but not tested.

- ** These parameters are design targets and are not tested. No characterization data available at this time.
- † Data in the Typical ("Typ") column is at 5V, 25°C unless otherwise stated. These parameters are for design guidance only and are not tested.

Note 1: Measurements are taken in RC Mode where CLKOUT output is 4 x Tosc.

2: Refer to Figure 19-2 for load conditions.

© 1997-2013 Microchip Technology Inc.

w

W Register	
Value on reset	20
Wake-up from SLEEP	19, 47
Watchdog Timer (WDT)	43, 46
Period	
Programming Considerations	
Register values on reset	
WWW, On-Line Support	3
X	
XORLW	60
XORWF	60
Z	
Zero (Z) bit	9, 29

NOTES: